IN THE SPECIFICATION

Please replace the paragraph beginning on Page 10, Line 6 with the following:

-- Figure 1d illustrates subsequent fabrication that is carried out on the monocrystalline silicon wafer 10. First, an epitaxial silicon layer 14 is grown on the monocrystalline silicon wafer 10. The epitaxial silicon layer 14 follows the crystal structure of the monocrystalline silicon wafer 10 and is thus also monocrystalline. A primary difference between the epitaxial silicon layer 14 and the monocrystalline silicon wafer 10 is that the expitaxial silicon layer 14 includes dopants. As such, the epitaxial silicon layer 14 is either n-doped or p-doped. --

Please replace the paragraph beginning on Page 10, Line 13 with the following:

or 16B includes a plurality of semiconductor electronic components such as transistors, capacitors, diodes, etc., and upper-level metallization which connect the electronic components. A transistor has source and drain regions that are implanted into the epitaxial silicon layer 14. These source and drain regions have opposite doping than the bulk of the epitaxial silicon layer 14. The source and drain regions are implanted to a required depth into the epitaxial silicon layer 14 but usually not all the way through the epitaxial silicon layer 14 so that

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